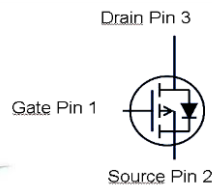
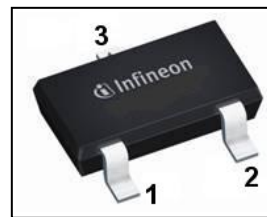


SIPMOS[®] Small-Signal-Transistor
Features

- P-Channel
- Enhancement mode
- Logic level
- Footprint and pinning compatible with SOT-23 / SuperSOT-23 packages
- Avalanche rated
- Pb-free lead finishing; RoHS compliant
- Qualified according to AEC Q101
- Halogen free according to IEC61249-2-21

Product Summary

| | | |
|------------------|-------|----------|
| V_{DS} | -60 | V |
| $R_{DS(on),max}$ | 0.8 | Ω |
| I_D | -0.62 | A |


SC-59


| Type | Package | Tape and reel information | Marking | Halogen-free | Packing |
|---------|---------|---------------------------|---------|--------------|---------|
| BSR315P | PG-SC59 | H6327 = 3000 pcs. / reel | LB | Yes | Non dry |

Maximum ratings, at $T_j=25\text{ °C}$, unless otherwise specified

| Parameter | Symbol | Conditions | Value | Unit |
|-------------------------------------|----------------|---|------------------------|--------------------|
| | | | steady state | |
| Continuous drain current | I_D | $T_A=25\text{ °C}$ | -0.62 | A |
| | | $T_A=70\text{ °C}$ | -0.49 | |
| Pulsed drain current | $I_{D,pulse}$ | $T_A=25\text{ °C}$ | -2.48 | |
| Avalanche energy, single pulse | E_{AS} | $I_D=0.62\text{ A}$, $R_{GS}=25\ \Omega$ | 24 | mJ |
| Gate source voltage | V_{GS} | | ± 20 | V |
| Power dissipation | P_{tot} | $T_A=25\text{ °C}$ | 0.5 | W |
| Operating and storage temperature | T_j, T_{stg} | | -55 ... 150 | $^{\circ}\text{C}$ |
| ESD class | | JESD22-C101 | 1A (250V to 500V) | |
| Soldering temperature | | | 260 $^{\circ}\text{C}$ | |
| IEC climatic category; DIN IEC 68-1 | | | 55/150/56 | |

| Parameter | Symbol | Conditions | Values | | | Unit |
|-----------|--------|------------|--------|------|------|------|
| | | | min. | typ. | max. | |

Thermal characteristics

| | | | | | | |
|--|------------|---------------------------------|---|---|-----|-----|
| Thermal resistance, junction - ambient | R_{thJA} | minimal footprint, steady state | - | - | 250 | K/W |
|--|------------|---------------------------------|---|---|-----|-----|

Electrical characteristics, at $T_j=25\text{ °C}$, unless otherwise specified
Static characteristics

| | | | | | | |
|----------------------------------|---------------|---|-----|------|------|------------------|
| Drain-source breakdown voltage | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}$, $I_D=-250\text{ }\mu\text{A}$ | -60 | - | - | V |
| Gate threshold voltage | $V_{GS(th)}$ | $V_{DS}=V_{GS}$, $I_D=-160\text{ }\mu\text{A}$ | -1 | -1.5 | -2 | |
| Zero gate voltage drain current | I_{DSS} | $V_{DS}=-60\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ °C}$ | - | -0.1 | -1 | μA |
| | | $V_{DS}=-60\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=150\text{ °C}$ | - | -10 | -100 | |
| Gate-source leakage current | I_{GSS} | $V_{GS}=-20\text{ V}$, $V_{DS}=0\text{ V}$ | - | -10 | -100 | nA |
| Drain-source on-state resistance | $R_{DS(on)}$ | $V_{GS}=-4.5\text{ V}$, $I_D=-0.49\text{ A}$ | - | 870 | 1300 | $\text{m}\Omega$ |
| | | $V_{GS}=-10\text{ V}$, $I_D=-0.62\text{ A}$ | - | 620 | 800 | |
| Transconductance | g_{fs} | $ V_{DS} >2 I_D R_{DS(on)max}$, $I_D=-0.49\text{ A}$ | 0.5 | 0.9 | - | S |

| Parameter | Symbol | Conditions | Values | | | Unit |
|-----------|--------|------------|--------|------|------|------|
| | | | min. | typ. | max. | |

Dynamic characteristics²⁾

| | | | | | | |
|------------------------------|--------------|---|---|-----|-----|----|
| Input capacitance | C_{iss} | $V_{GS}=0\text{ V}, V_{DS}=-25\text{ V},$ $f=1\text{ MHz}$ | - | 132 | 176 | pF |
| Output capacitance | C_{oss} | | - | 42 | 56 | |
| Reverse transfer capacitance | C_{rss} | | - | 20 | 30 | |
| Turn-on delay time | $t_{d(on)}$ | $V_{DD}=-30\text{ V},$ $V_{GS}=-10\text{ V},$ $I_D=-0.62\text{ A}, R_{G,ext}=6\ \Omega$ | - | 8 | 13 | ns |
| Rise time | t_r | | - | 28 | 46 | |
| Turn-off delay time | $t_{d(off)}$ | | - | 21 | 32 | |
| Fall time | t_f | | - | 20 | 30 | |

Gate Charge Characteristics^{1),2)}

| | | | | | | |
|-----------------------|---------------|---|---|-----|-----|----|
| Gate to source charge | Q_{gs} | $V_{DD}=-48\text{ V},$ $I_D=-0.62\text{ A}, V_{GS}=0\text{ to }-10\text{ V}$ | - | 0.4 | 0.5 | nC |
| Gate to drain charge | Q_{gd} | | - | 2 | 3 | |
| Gate charge total | Q_g | | - | 4 | 6 | |
| Gate plateau voltage | $V_{plateau}$ | | - | -3 | - | V |

Reverse Diode

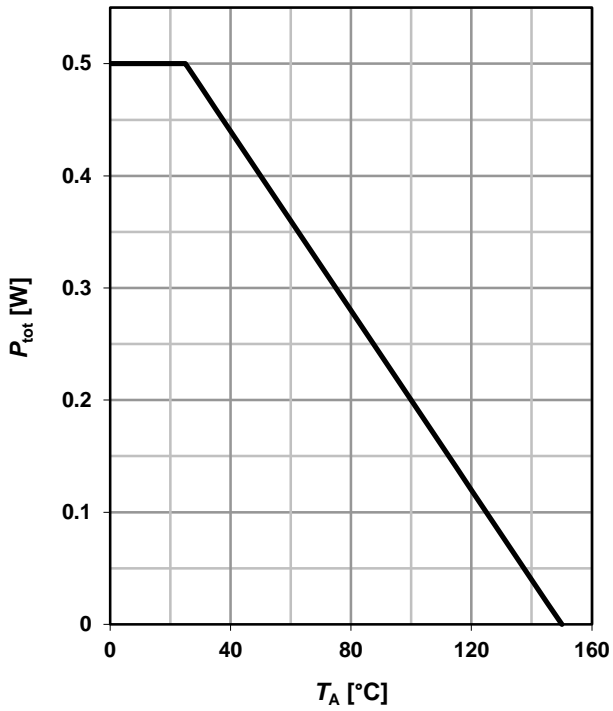
| | | | | | | |
|---------------------------------------|---------------|--|---|-------|-------|----|
| Diode continuous forward current | I_S | $T_A=25\text{ °C}$ | - | - | -0.56 | A |
| Diode pulse current | $I_{S,pulse}$ | | - | - | -2.5 | |
| Diode forward voltage | V_{SD} | $V_{GS}=0\text{ V}, I_F=-0.62\text{ A},$ $T_j=25\text{ °C}$ | - | -0.82 | -1.2 | V |
| Reverse recovery time ²⁾ | t_{rr} | $V_R=-30\text{ V}, I_F= I_S ,$ $di_F/dt=100\text{ A}/\mu\text{s}$ | - | 32 | 48 | ns |
| Reverse recovery charge ²⁾ | Q_{rr} | | - | 29 | 43 | nC |

²⁾Defined by design. Not subjected to production test

¹⁾ See figure 16 for gate charge parameter definition

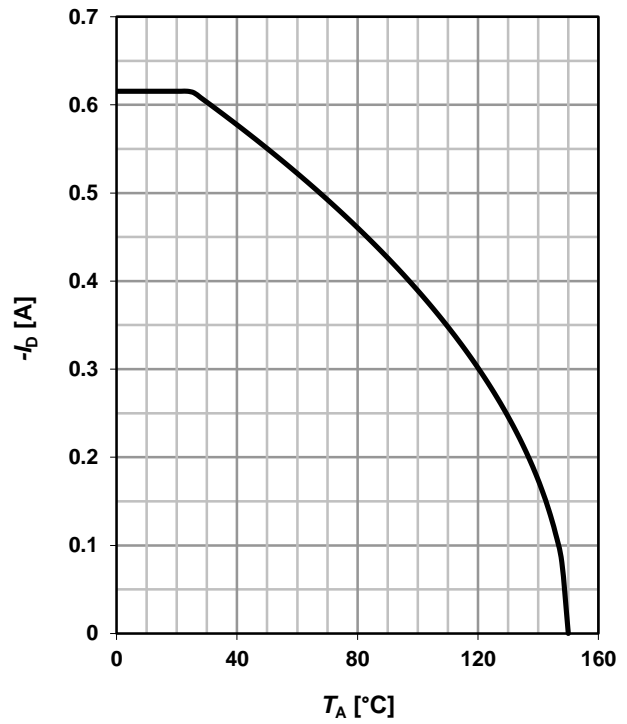
1 Power dissipation

$P_{tot}=f(T_A)$



2 Drain current

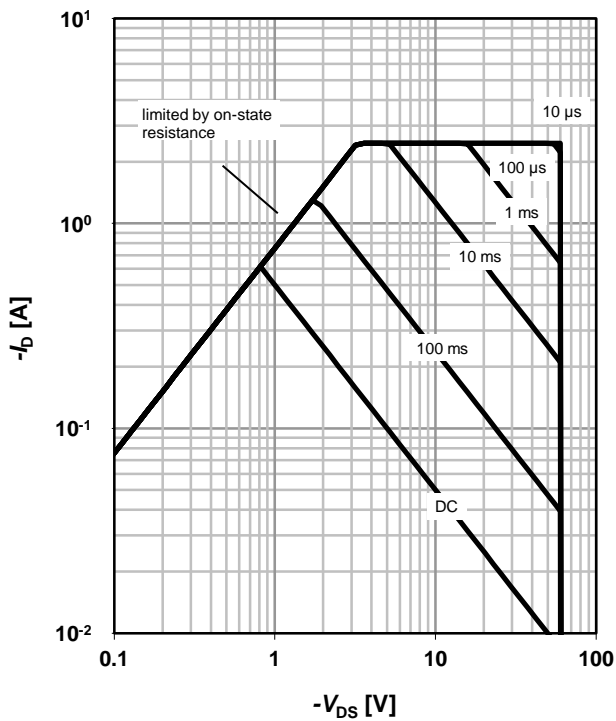
$I_D=f(T_A); |V_{GS}| \geq 10\text{ V}$



3 Safe operating area

$I_D=f(V_{DS}); T_A=25\text{ °C}; D=0$

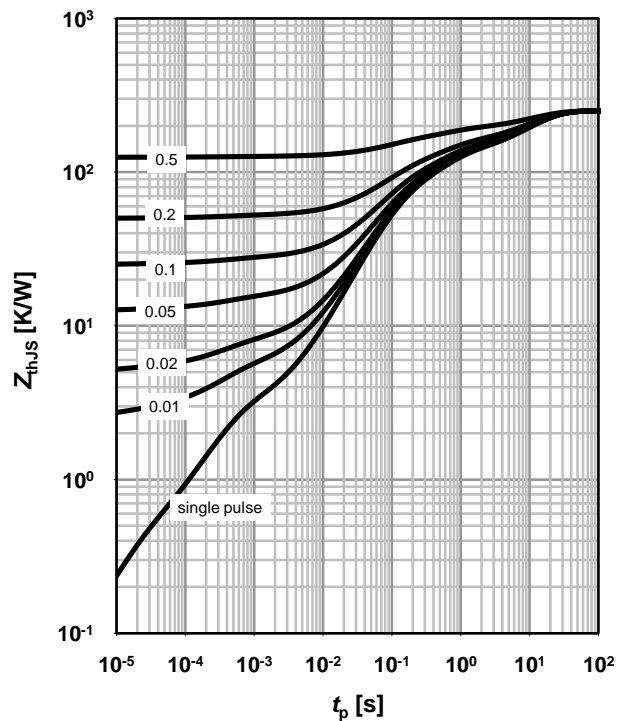
parameter: t_p



4 Max. transient thermal impedance

$Z_{thJA}=f(t_p)$

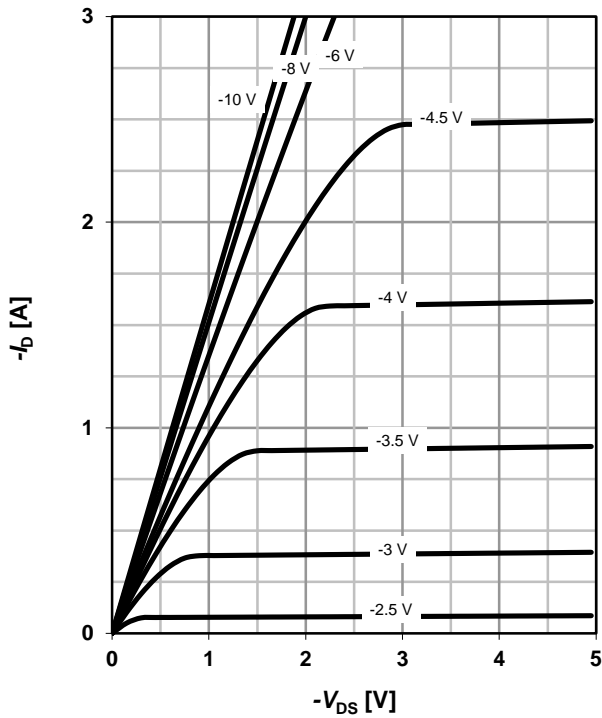
parameter: $D=t_p/T$



5 Typ. output characteristics

$I_D=f(V_{DS}); T_j=25\text{ }^\circ\text{C}$

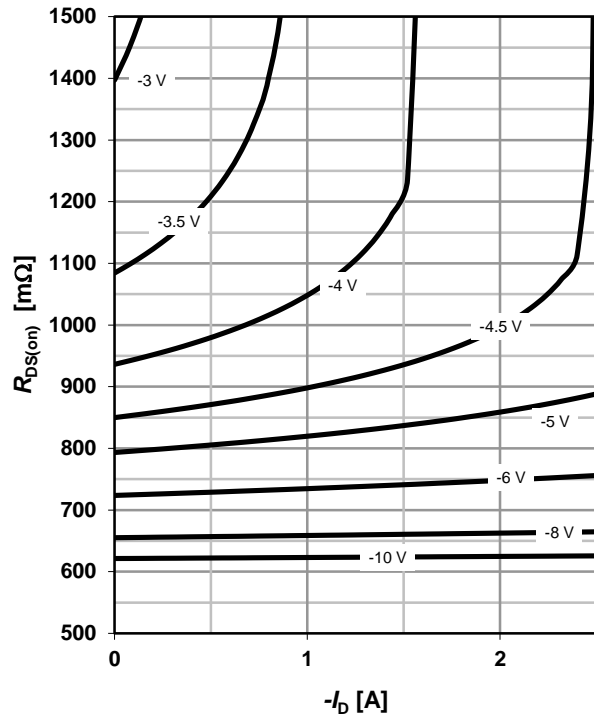
parameter: V_{GS}



6 Typ. drain-source on resistance

$R_{DS(on)}=f(I_D); T_j=25\text{ }^\circ\text{C}$

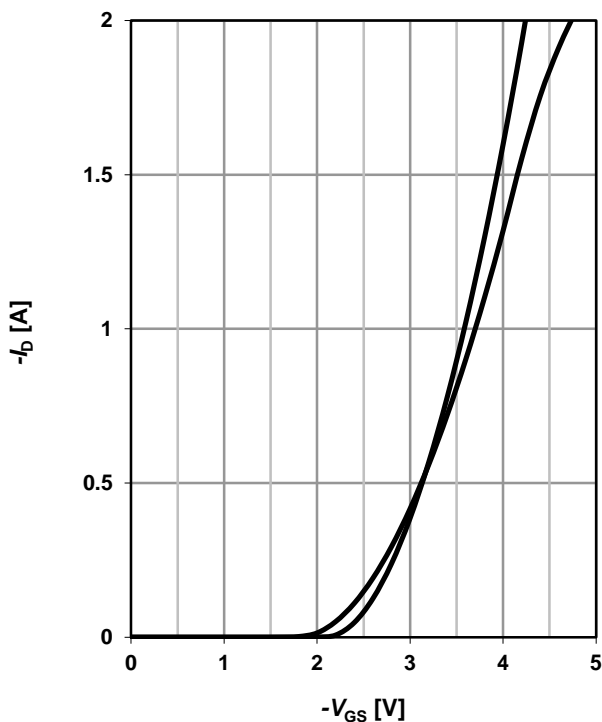
parameter: V_{GS}



7 Typ. transfer characteristics

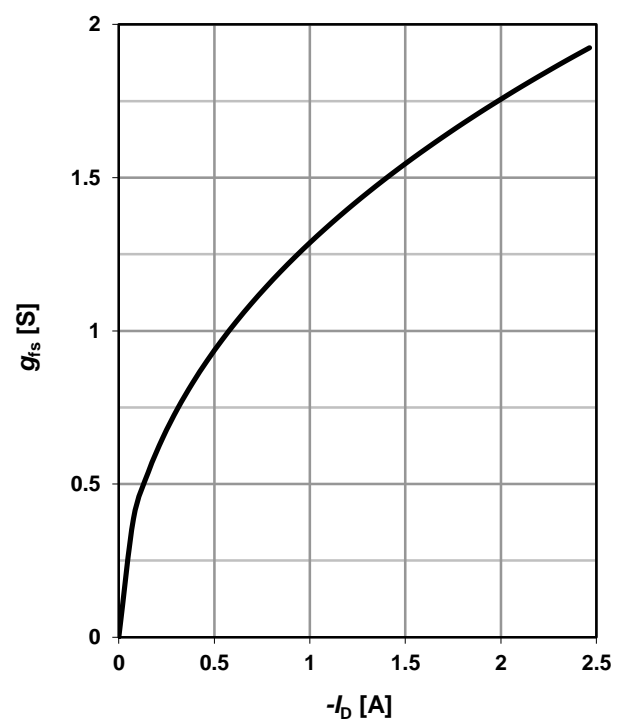
$I_D=f(V_{GS}); |V_{DS}|>2|I_D|R_{DS(on)max}$

parameter: T_j



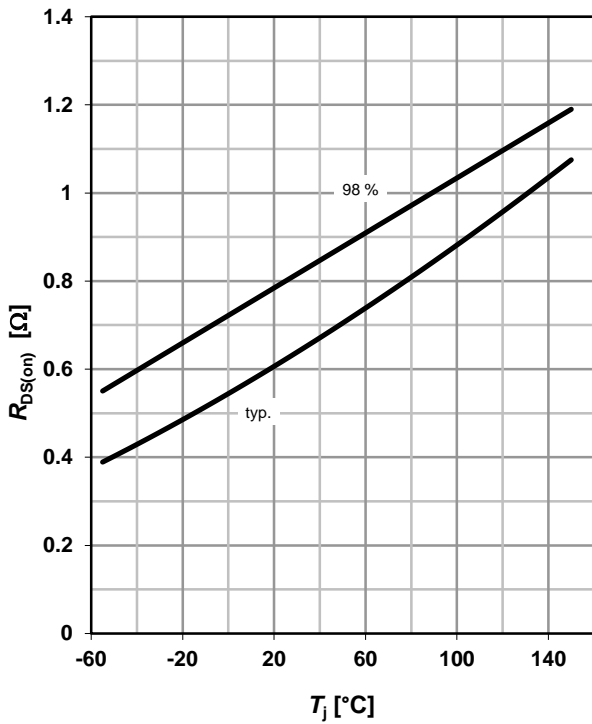
8 Typ. forward transconductance

$g_{fs}=f(I_D); T_j=25\text{ }^\circ\text{C}$



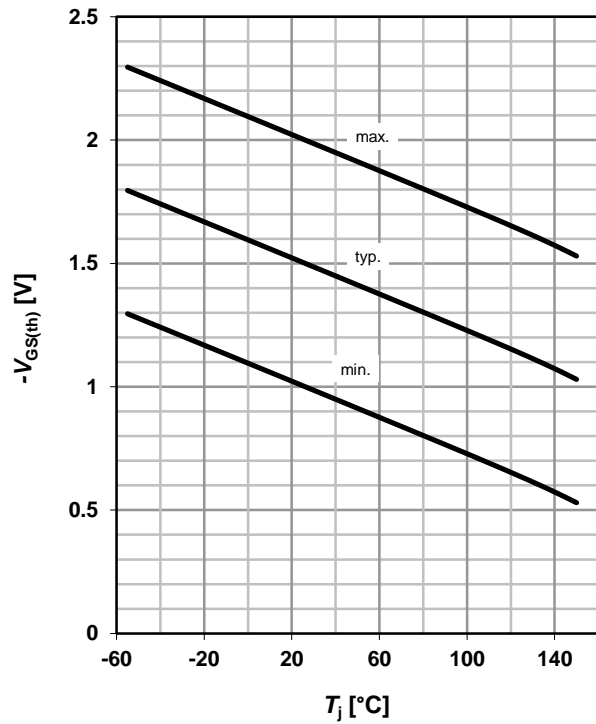
9 Drain-source on-state resistance

$R_{DS(on)}=f(T_j); I_D=-0.62\text{ A}; V_{GS}=-10\text{ V}$



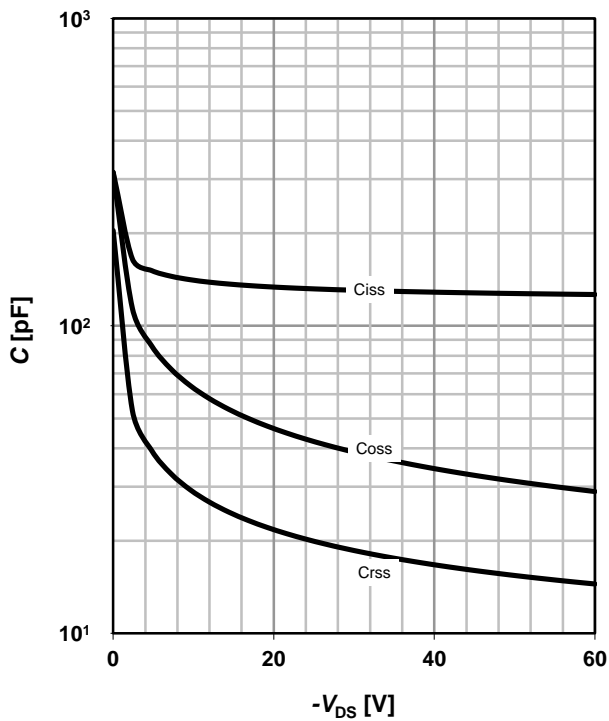
10 Typ. gate threshold voltage

$V_{GS(th)}=f(T_j); V_{GS}=V_{DS}; I_D=-160\text{ }\mu\text{A}$



11 Typ. capacitances

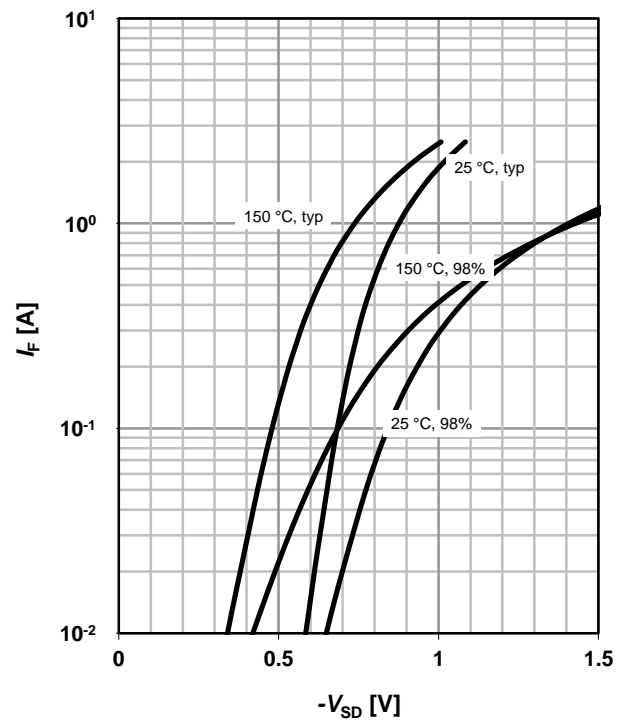
$C=f(V_{DS}); V_{GS}=0\text{ V}; f=1\text{ MHz}$



12 Forward characteristics of reverse diode

$I_F=f(V_{SD})$

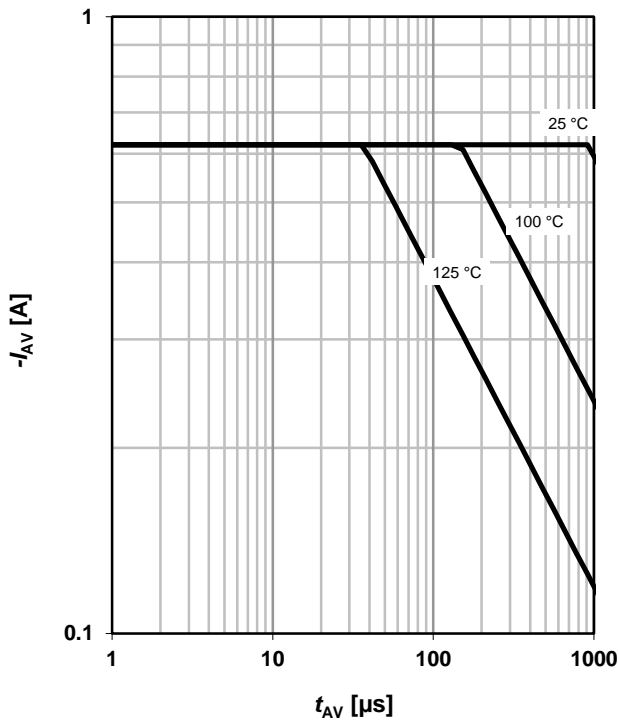
parameter: T_j



13 Avalanche characteristics

$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

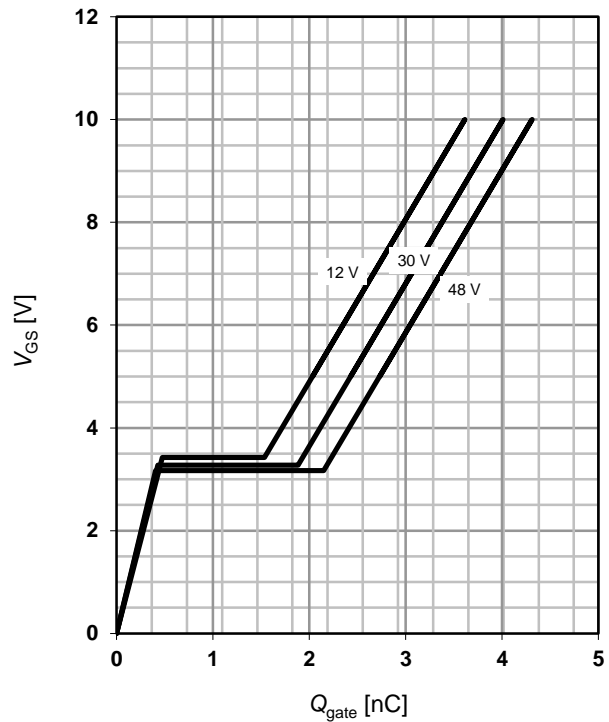
parameter: $T_{j(start)}$



14 Typ. gate charge

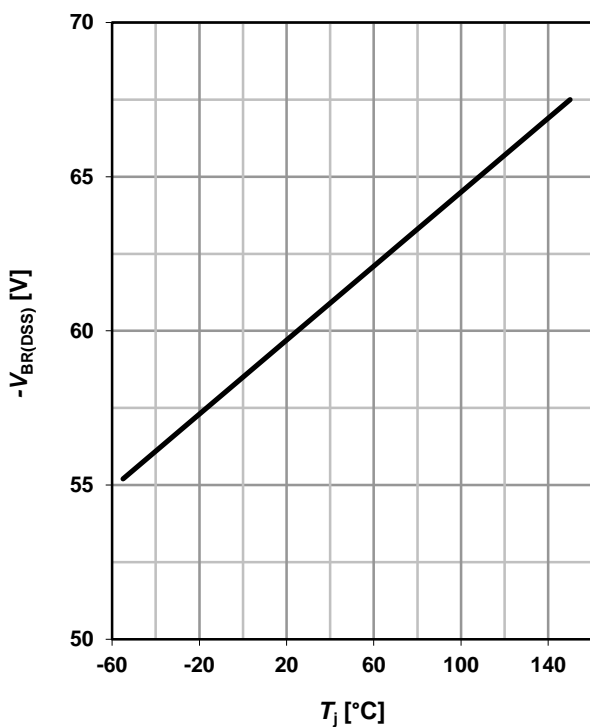
$V_{GS}=f(Q_{gate}); I_D=-0.62 \text{ A pulsed}$

parameter: V_{DD}

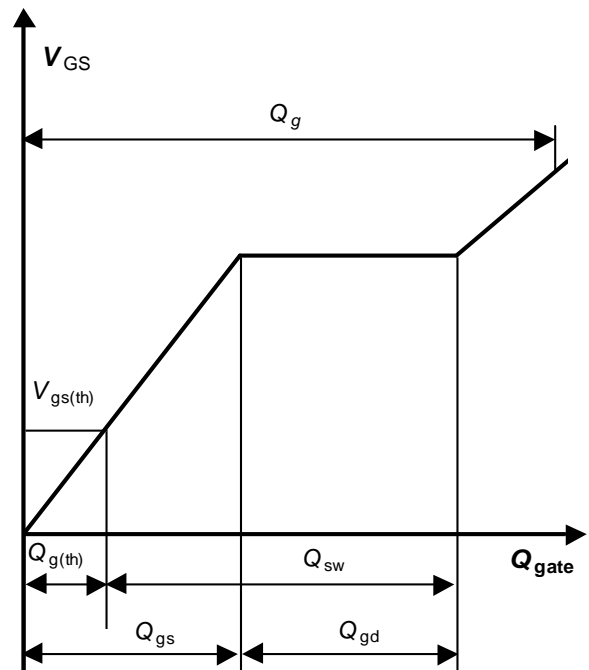


15 Drain-source breakdown voltage

$V_{BR(DSS)}=f(T_j); I_D=-250 \mu\text{A}$



16 Gate charge waveforms



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